

## SMPS MOSFET

**IRF7453**

HEXFET® Power MOSFET

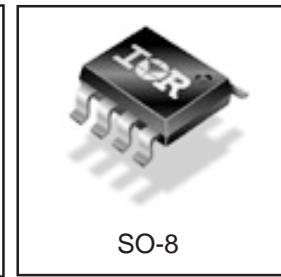
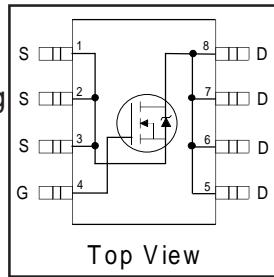
### Applications

- High frequency DC-DC converters

V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
250V	0.23Ω@V <sub>GS</sub> = 10V	2.2A

### Benefits

- Low Gate to Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C<sub>OSS</sub> to Simplify Design (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current



### Absolute Maximum Ratings

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	2.2	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	1.7	
I <sub>DM</sub>	Pulsed Drain Current ①	17	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation④	2.5	W
	Linear Derating Factor	0.02	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 30	V
dv/dt	Peak Diode Recovery dv/dt ⑥	13	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

### Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R <sub>θJL</sub>	Junction-to-Drain Lead	—	20	°C/W
R <sub>θJA</sub>	Junction-to-Ambient ④	—	50	

Notes ① through ⑥ are on page 8

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# IRF7453

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## Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	250	—	—	V	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.33	—	$\text{V}^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$ ③
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.23	$\Omega$	$V_{\text{GS}} = 10\text{V}, I_D = 1.3\text{A}$ ③
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	3.0	—	5.5	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{\text{DS}} = 250\text{V}, V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 200\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$V_{\text{GS}} = 24\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -24\text{V}$

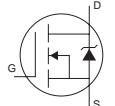
## Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

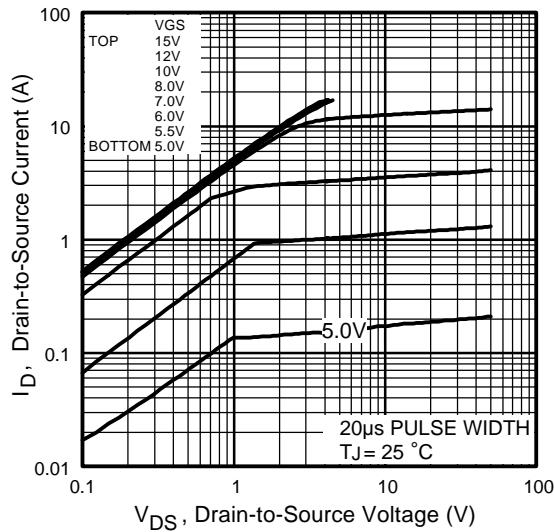
	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{\text{fs}}$	Forward Transconductance	1.8	—	—	S	$V_{\text{DS}} = 50\text{V}, I_D = 1.3\text{A}$
$Q_g$	Total Gate Charge	—	25	38	nC	$I_D = 1.3\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	6.0	9.0		$V_{\text{DS}} = 200\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	11	17		$V_{\text{GS}} = 10\text{V},$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	9.0	—		$V_{\text{DD}} = 125\text{V}$
$t_r$	Rise Time	—	2.5	—	ns	$I_D = 1.3\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	19	—		$R_G = 6.0\Omega$
$t_f$	Fall Time	—	20	—		$V_{\text{GS}} = 10\text{V}$ ③
$C_{\text{iss}}$	Input Capacitance	—	930	—		$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	130	—	pF	$V_{\text{DS}} = 25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	23	—		$f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	1050	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 1.0\text{V}, f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	52	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 200\text{V}, f = 1.0\text{MHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance	—	96	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V to } 200\text{V}$ ⑤

## Avalanche Characteristics

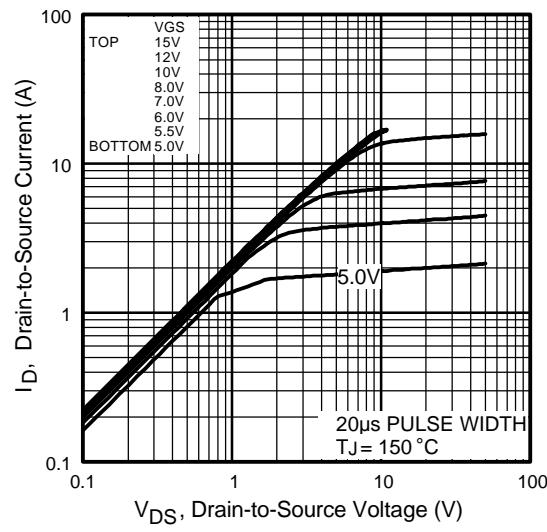
	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	200	mJ
$I_{\text{AR}}$	Avalanche Current ①	—	2.2	A

## Diode Characteristics

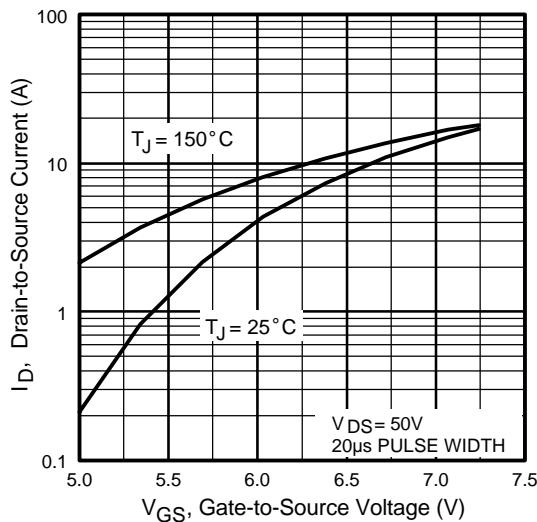
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s$	Continuous Source Current (Body Diode)	—	—	2.3	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	17		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 1.3\text{A}, V_{\text{GS}} = 0\text{V}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	98	150	ns	$T_J = 25^\circ\text{C}, I_F = 1.3\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	340	510	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ③



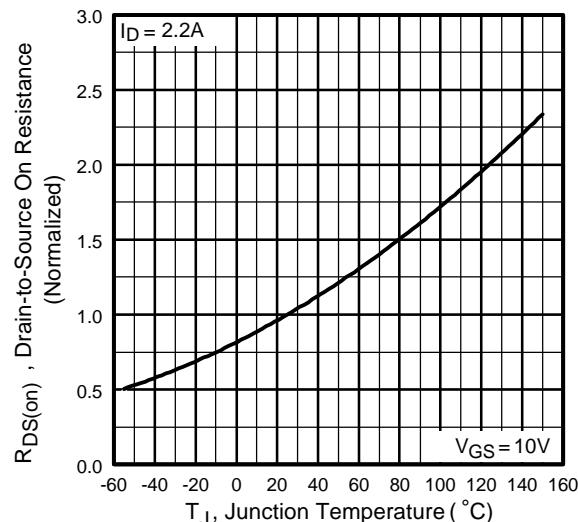
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



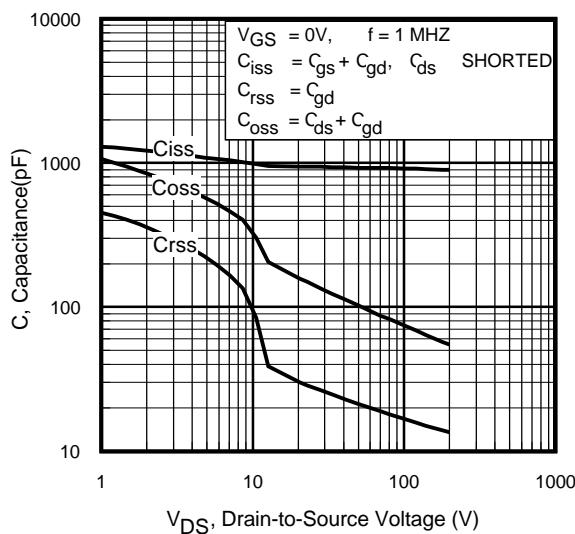
**Fig 3.** Typical Transfer Characteristics



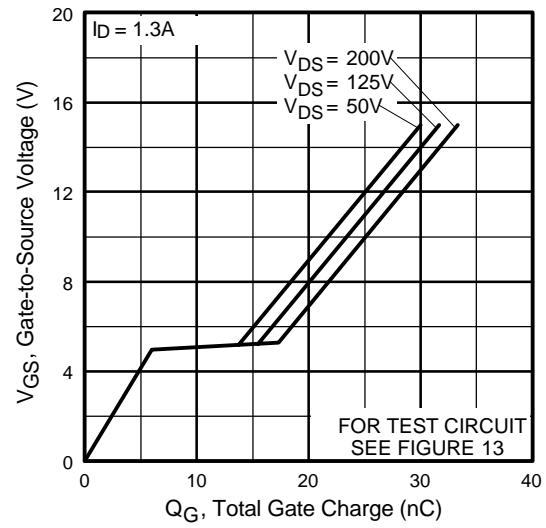
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

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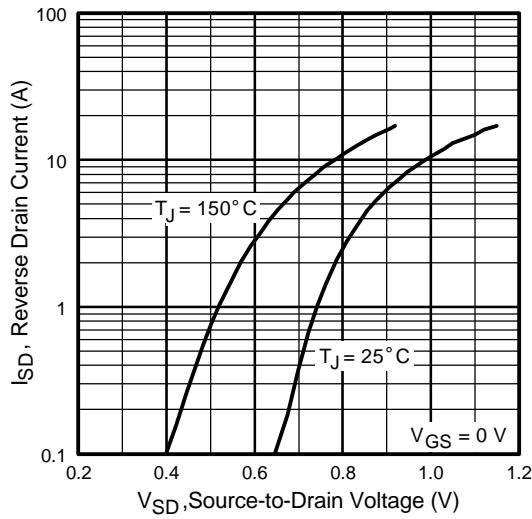
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Rectifier



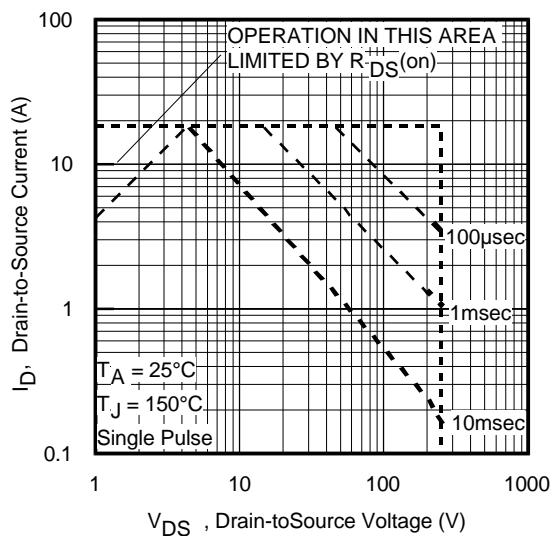
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



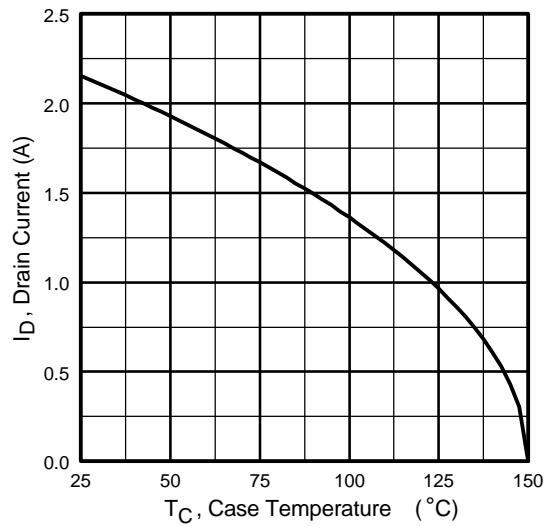
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



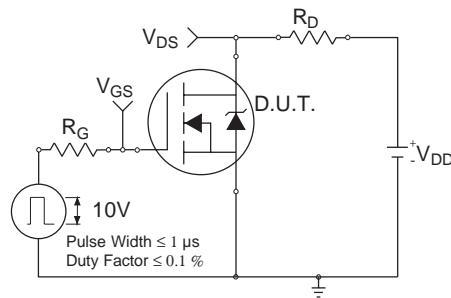
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



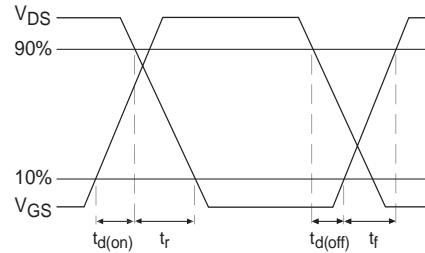
**Fig 8.** Maximum Safe Operating Area



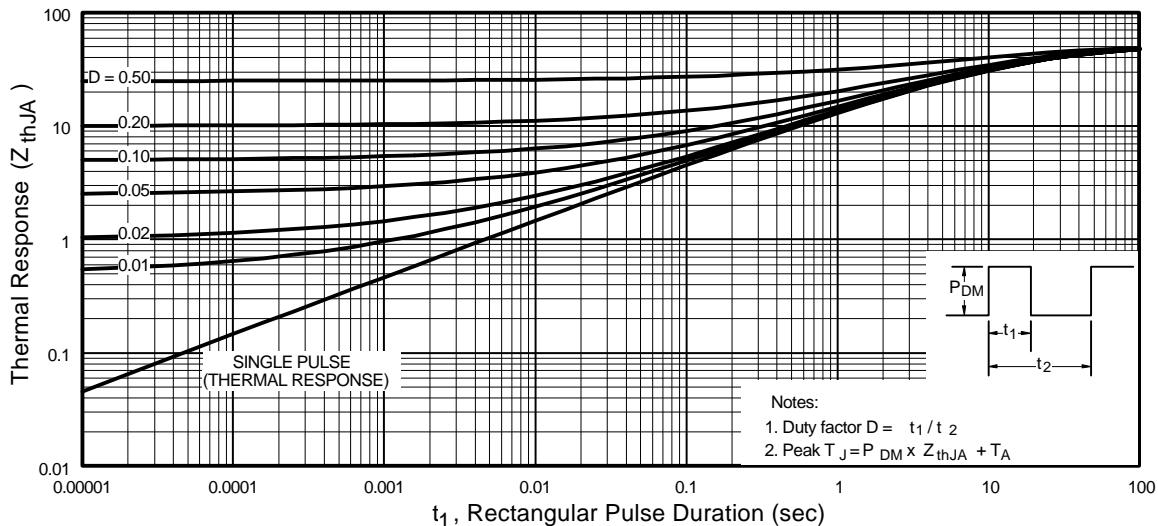
**Fig 9.** Maximum Drain Current Vs.  
Ambient Temperature



**Fig 10a.** Switching Time Test Circuit



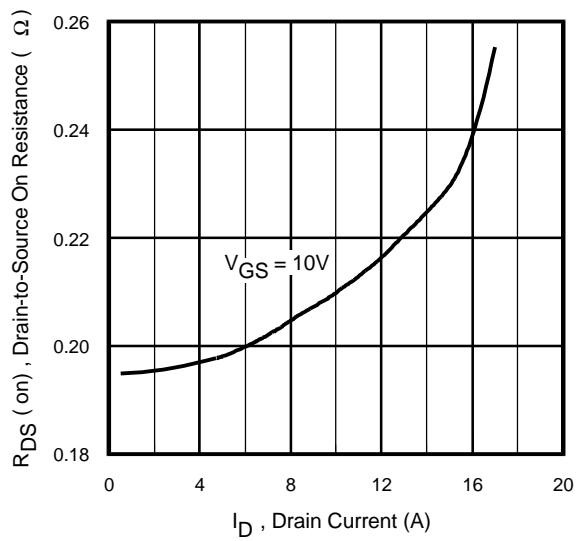
**Fig 10b.** Switching Time Waveforms



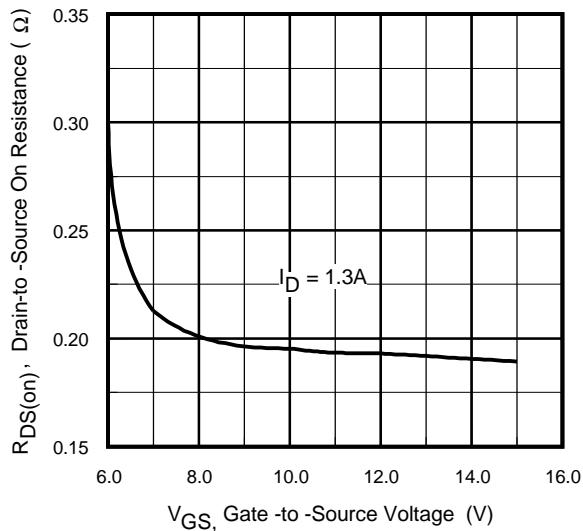
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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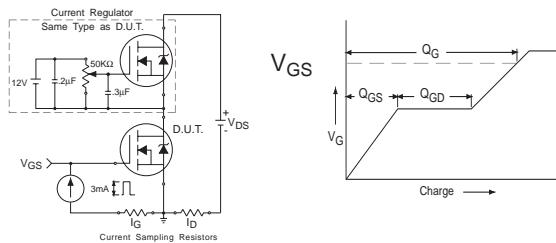
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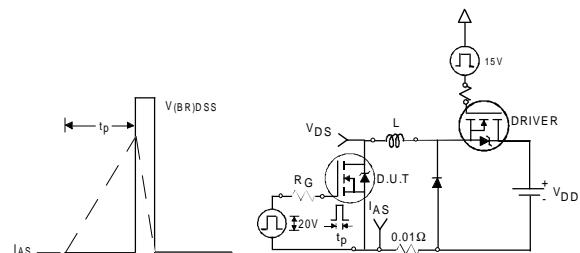
**Fig 12.** On-Resistance Vs. Drain Current



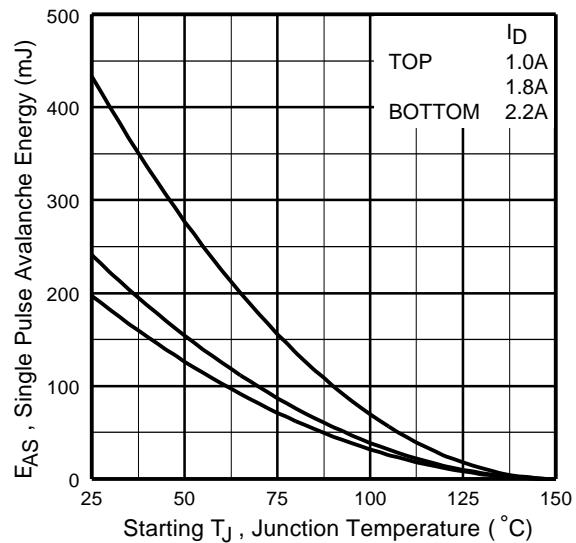
**Fig 13.** On-Resistance Vs. Gate Voltage



**Fig 14a&b.** Basic Gate Charge Test Circuit and Waveform

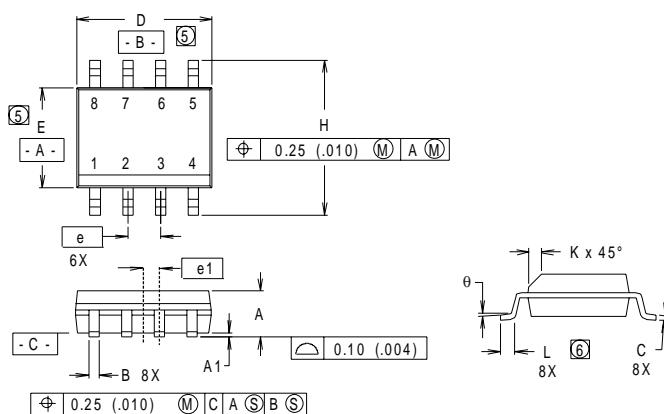


**Fig 15a&b.** Unclamped Inductive Test circuit and Waveforms



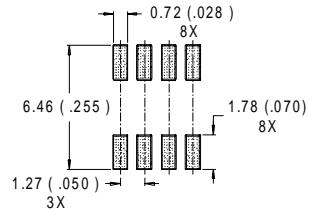
**Fig 15c.** Maximum Avalanche Energy Vs. Drain Current

## SO-8 Package Details



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
B	.014	.018	0.36	0.46
C	.0075	.0098	0.19	0.25
D	.189	.196	4.80	4.98
E	.150	.157	3.81	3.99
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.011	.019	0.28	0.48
L	0.16	.050	0.41	1.27
$\theta$	0°	8°	0°	8°

RECOMMENDED FOOTPRINT

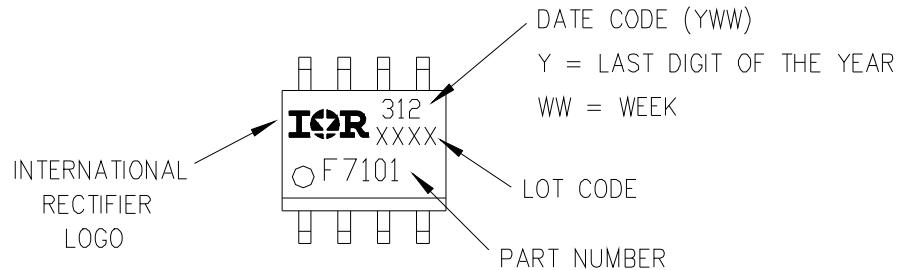


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1982.
2. CONTROLLING DIMENSION : INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- ⑤ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS  
MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.006).
- ⑥ DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE..

## SO-8 Part Marking

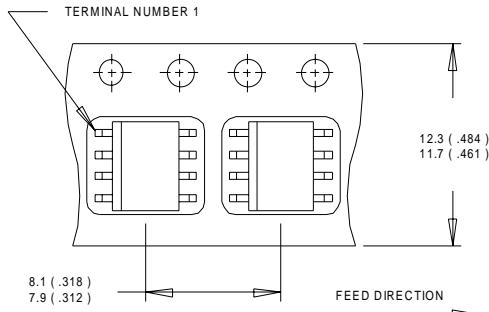
EXAMPLE: THIS IS AN IRF7101



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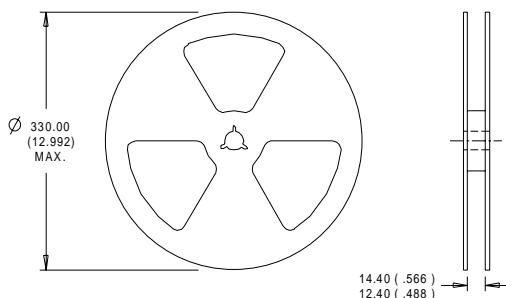
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## SO-8 Tape and Reel



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



### NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

### Notes:

- |  |   |
|--|---|
| ① Repetitive rating; pulse width limited by max. junction temperature.                                 | ③ Pulse width $\leq$ 400 $\mu$ s; duty cycle $\leq$ 2%. |
| ② Starting $T_J = 25^\circ\text{C}$ , $L = 83\text{mH}$<br>$R_G = 25\Omega$ , $I_{AS} = 2.2\text{A}$ . | ④ When mounted on 1 inch square copper board            |

Data and specifications subject to change without notice.  
This product has been designed and qualified for the industrial market.  
Qualification Standards can be found on IR's Web site.

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